Digital Design and Verification of the Front-end readout chip for ITk Strip upgrade

Weiguo Lu

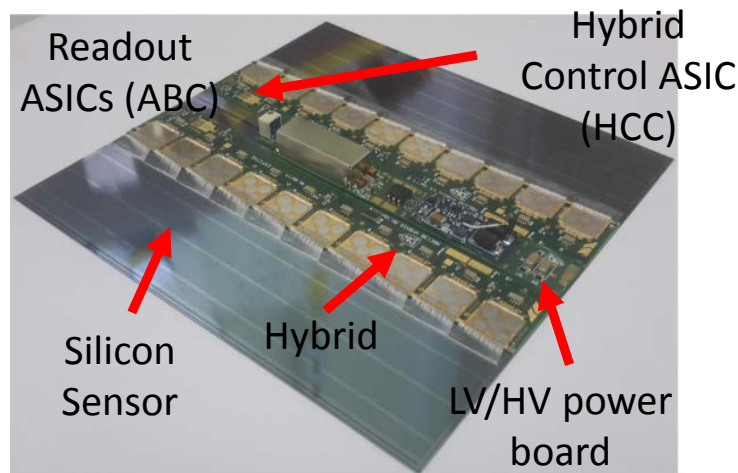IHEP

Dec. 23, 2017

Outline

- Chipset for ITk strip upgrade
- New design features of ABCStar
- Functional Verification
- Other blocks and current status

Chipset for ITk strip upgrade

Star chips for ITk Strip

Readout ASICs (ABC)

Hybrid Control ASIC (HCC)

Silicon Sensor

Hybrid

LV/HV power board

- Challenge for ITk Strip upgrade
  - Higher luminosity , finer granularity, larger scale, harsher radiation…
- Chipset on module
  - ABC--ATLAS Binary Chip
  - HCC--Hybrid Control Chip
- Star architecture on hybrid
  - Increased trigger rate->1MHz L0
  - shorter latency
 - From serial transfer to star connection
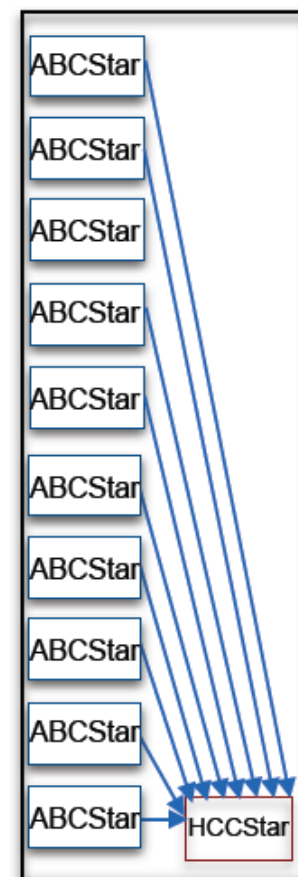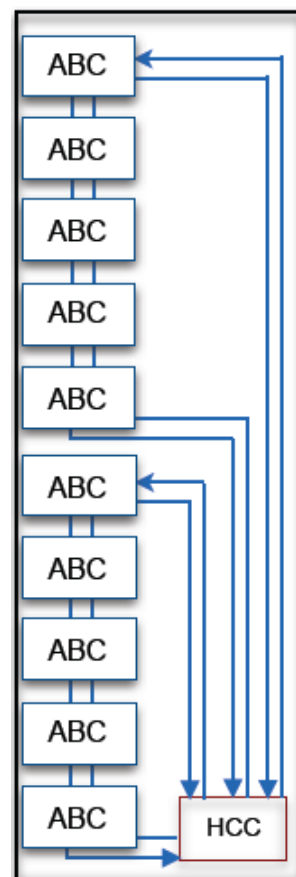
Design group

- Francis Anghinolfi, Jan Kaplon (CERN)
- Mitchell Franck Newcomer, Paul Keener, Aditya Narayan (University of Pennsylvania (US))
- Joel Nathan De Witt (University of California, Santa Cruz (US))
- Matt Warren (University College London (UK))
- Krzysztof Swientek (AGH University of Science and Technology (PL))
- Libo Cheng, Weiguo Lu (IHEP)

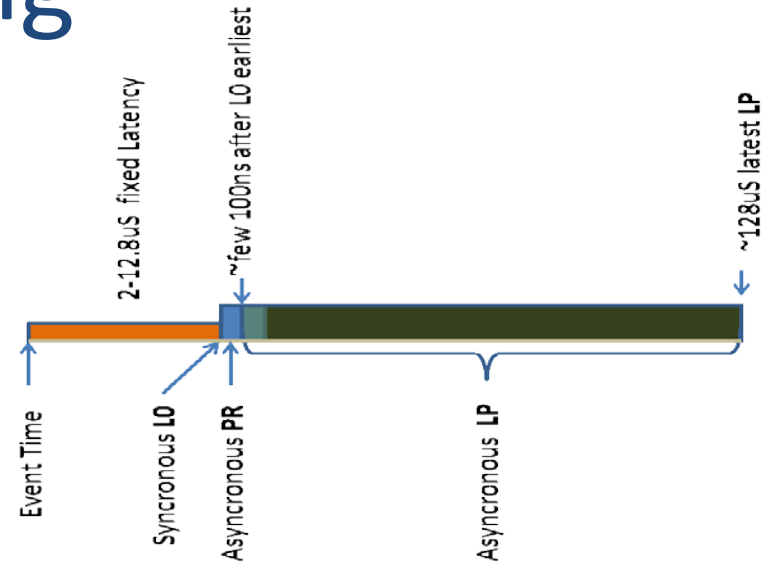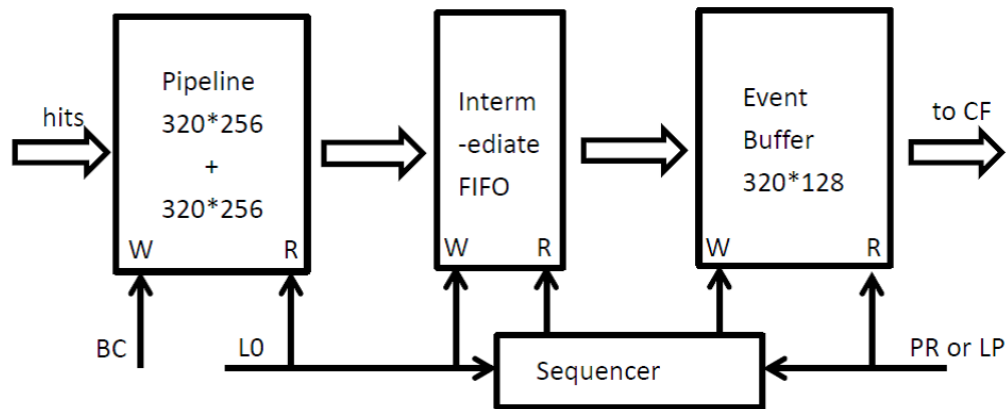# New design features of ABCStar

ABCStar ASIC
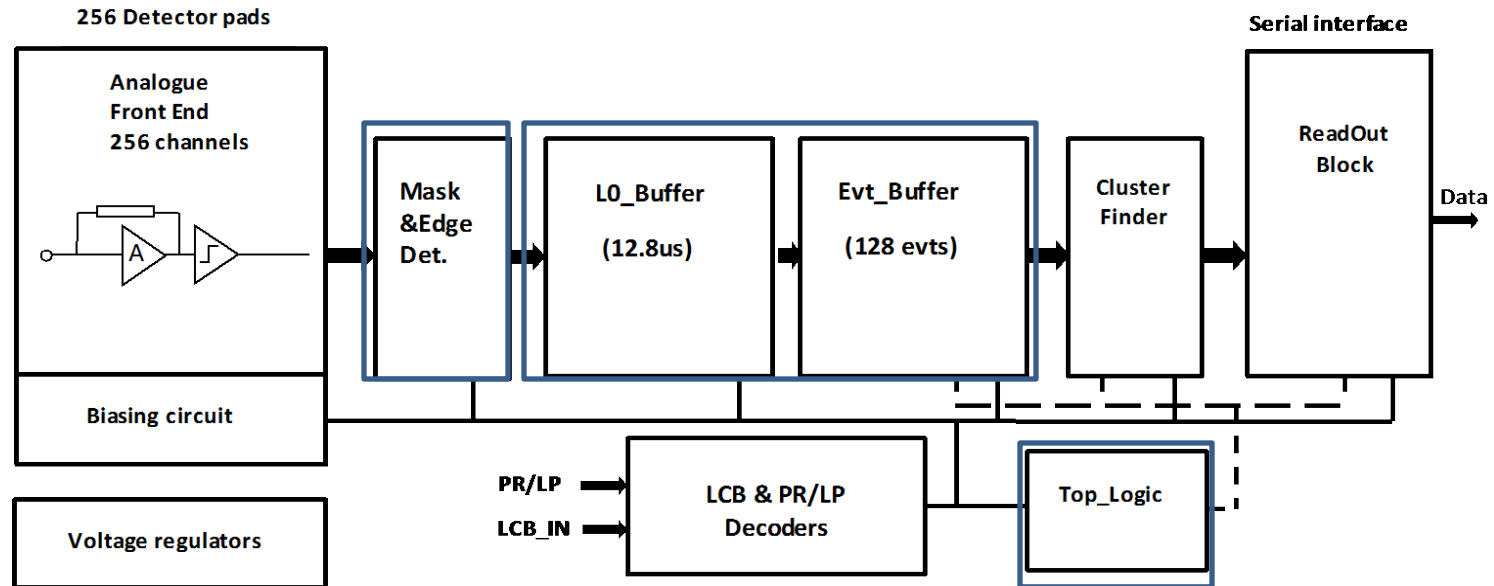
- Standard binary readout architecture
- Data path: amplifier, discriminator, input register block, pipeline, event buffer and a cluster algorithm to compress data for output
- Support various trigger modes
- GF130nm technology

Buffering

- The two stage buffers: Pipeline(L0Buffer) and EvtBuffer
- Changed trigger latency
  - Modification of buffer size
- Higher trigger rate
  - Transfer 1 event per L0 from Pipeline to EvtBuffer(instead of 3) ->Less RAM, simpler logic
  - Basic memory IP: single port RAM+ in case of consecutive L0s
    -->Intermediate FIFO to give the priority to EvtBuffer read operation

Data compression

ABC130

```
┌ ─ ─ ─ ─ ─ ─ ─ ─ ─ ─ ┐
│  Two stage buffer   │
└ ─ ─ ─ ─ ─ ─ ─ ─ ─ ─ ┘
          ↓
┌─────────────────────┐
│         DCL         │
└─────────────────────┘
```

ABCStar

```
┌─────────────────────┐
│    Edge detection   │
└─────────────────────┘
          ↓
┌ ─ ─ ─ ─ ─ ─ ─ ─ ─ ─ ┐
│  Two stage buffer   │
└ ─ ─ ─ ─ ─ ─ ─ ─ ─ ─ ┘
          ↓
┌─────────────────────┐
│    Cluster finder   │
└─────────────────────┘
```
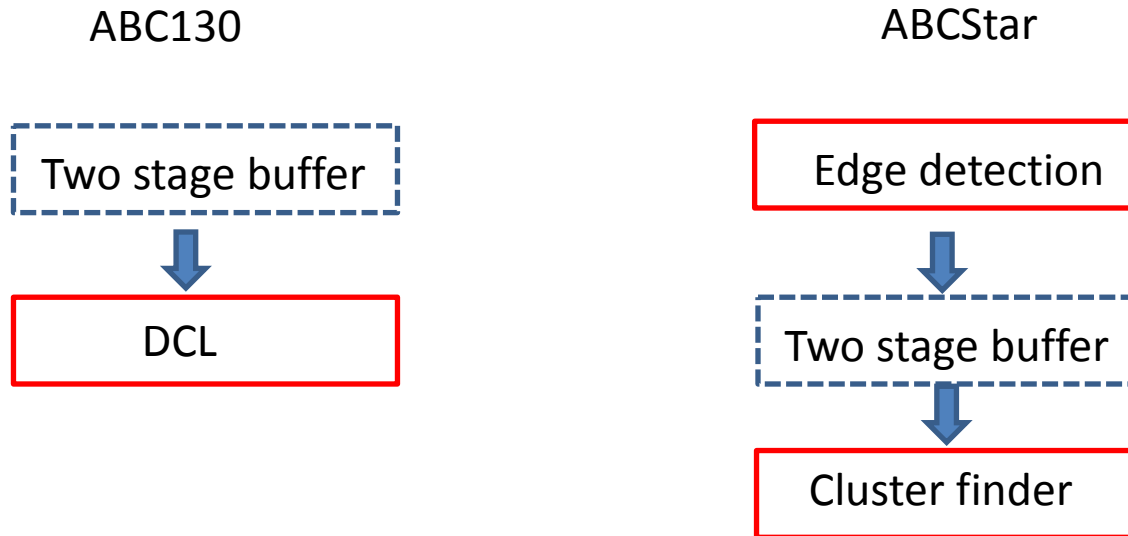
- Edge detection circuit before pipeline
  - Extract only the leading edge information
  - To compress the data in terms of time by factor of 2
- Cluster finder
  - Data reduction in terms of space, creating a cluster byte for channels found with hits
  - takes in 256 bits of strip data and reports out 12 bit clusters at 40MHz

Priority readout

- Physics data
  - PR trigger has higher priority over LP trigger
- Register readback
  - 32 positions Register Data FIFO
  - Two cases of conditions independent of read register command
- HPR
  - The content of the 32 bits register called "HPR" (for High Priority Register) is transmitted periodically after powerup, a HardReset, or a RegisterReset fast command, or in case of the lcb_lock bit being false, indicating the LCB circuit has lost its synchronization with the LCB signal frame.
- TopLogic
  - Sequencer for the control of EvtBuffer, ClusterFinder and ReadOut

high
HPR

PR

LP

low
Regular register readback
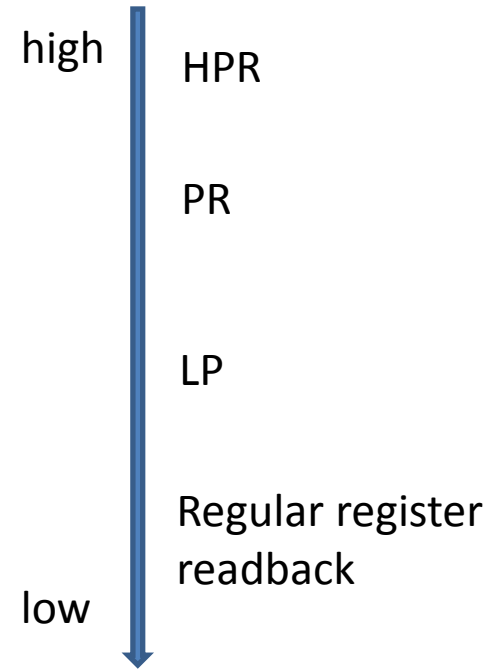
Interface

- **LCB**
  - The L0A/CMD/BCR - signal transfers triggers (L0A), fast-commands, register read-writes (CMD) and bunch-counter-reset (BCR) to the HCCStar and then onto the ABCSTAR
  - The signal is 6b8b encoded and sent at 160Mbps over an LVDS bus
  - 16 bits frame extending over 4BC
- **Data packets**
  - 68 bits fixed length readout packet format
  - 160Mb/s readout rate was rather chosen to reduce the transmission latency for L1-track

| Start Bits	Header	Payload	Trailer
3	16	48	1

Robust design

- L0tag insertion in LCB
  - Improve reliability by remove sensitive L0ID counter

- Deglitcher for external asynchronous resets

- Radiation hard design
  - TMR for key logic and registers
  - Hamming coded state machine

- …

Functional Verification

UVM setup

- A top verification setup based on (UVM)Universal Verification Methodology was built for ABCStar.
  - Functional coverage with customized random stimulus
  - Result comparison with reference model through scoreboard
  - SystemVerilog assertions for validating key design features
- To verify the current design under several possible trigger conditions
  - Different rate, latency and distribution model of triggers
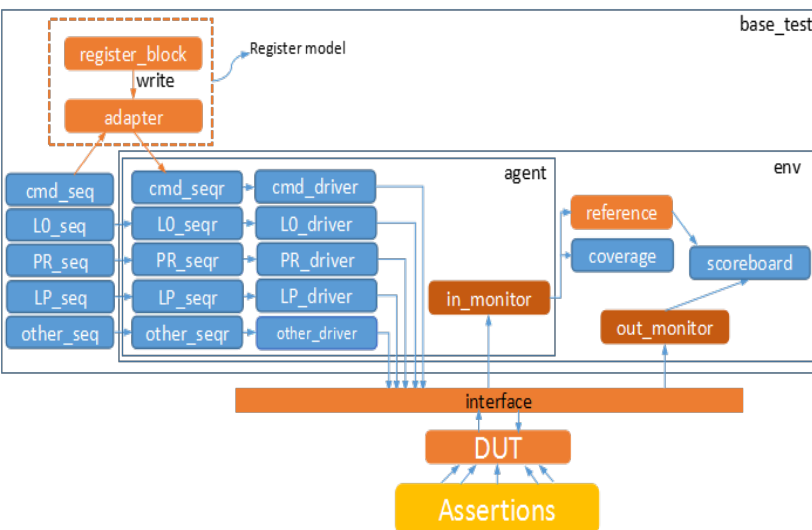
Trigger mode	description	Example tests with UVM setup
L0	Capture and readout at L0 rate	L0@1MHz, LP@1MHz
L0/LP	Capture data at L0, send requested data at LP rate	L0@4MHz, LP@1MHz
L0/PR/LP	Capture data at L0, send data with priority at PR rate, send remaining requested data at LP rate	L0@4MHz,LP@1MHz,PR@100KHz; L0@1MHz,LP@400KHz,PR@100KHz

SystemVerilog setup

- Unit tests
  - RTL level tests
  - Done at the module level
- Directed random tests
  - ABCStar golden model, SystemVerilog description of the ABCStar specs
  - Independent parallel process with random distributions & payloads.

List of test for ABC*

This document describes the list of unit test to be developed for ABC*

- Mixed signal simulation of analog blocks ADCs regs 0x01 to 0x07
  - DAC's
  - Ref bias
  - Mux
  - ADC's
- Data[0:255] and Mask[0:255] verify that masking works for all bits - full coverage of all individual bits of Data & Mask
- Functional test of test mode TM[0:1] with full coverage of all option and random input pattern Data[0:255]
- Registers read, write and reset as well as write disable
- Hit counter until complete fill + Fast commands Start, Stop, Enable
- L0 buffer, Event buffer full coverage of all positions LP/PR enable and full coverage of latency.
- Test of output sequencer and priority HPR, Register with RR mode, LP, PR
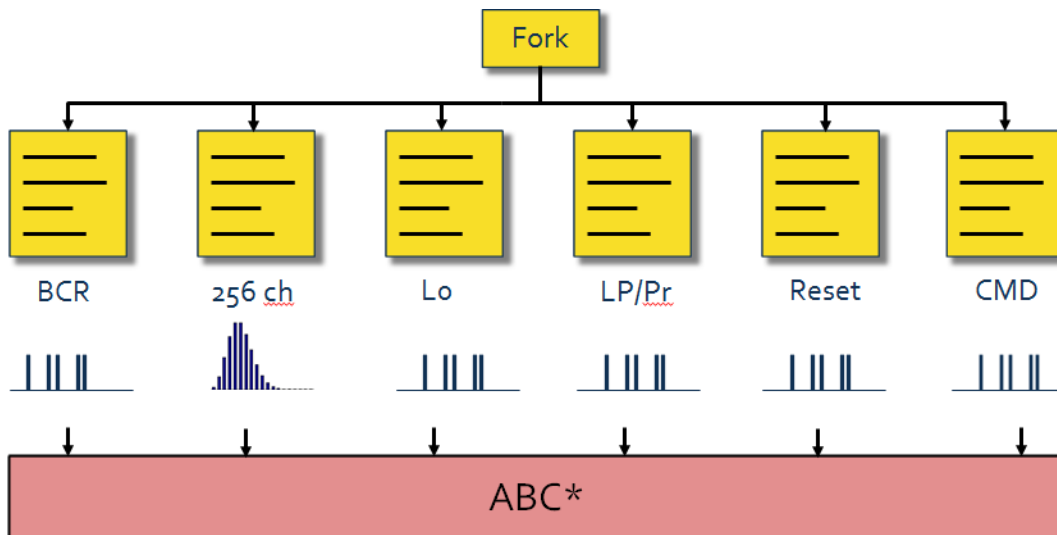- HPR functional test start stop mask reset and payload
- Calibration pulse length polarity
- Pad current drive in mixed signal
- BC offset check with full coverage of latency
- Max cluster full coverage
- Edge detection mode 0 to 30 consecutive BC's and sequence of random hits

Other blocks and current status

Analog part

- Front-end and ESD almost fixed
- Power options for TID current bump mitigation
  - extend the range of digital voltage regulator, lower voltage down to 1 volt for the digital part
- eFuse for chip identification
  - an individual chip identifier programmed with eFuses
- Analogue monitor of voltage and temperature
  - an analogue monitor circuit like in the HCC to measure regulated VDDs, and temperature

Summary

- In order to meet new challenges, many new features are adopted for ABCStar design, especially in the digital part

- rtl designs are close to the end, a lot of verification work ahead

- Analog blocks almost fixed, the layout has started

- Planned PDR in January 2018

Thanks for your attention !

simulation
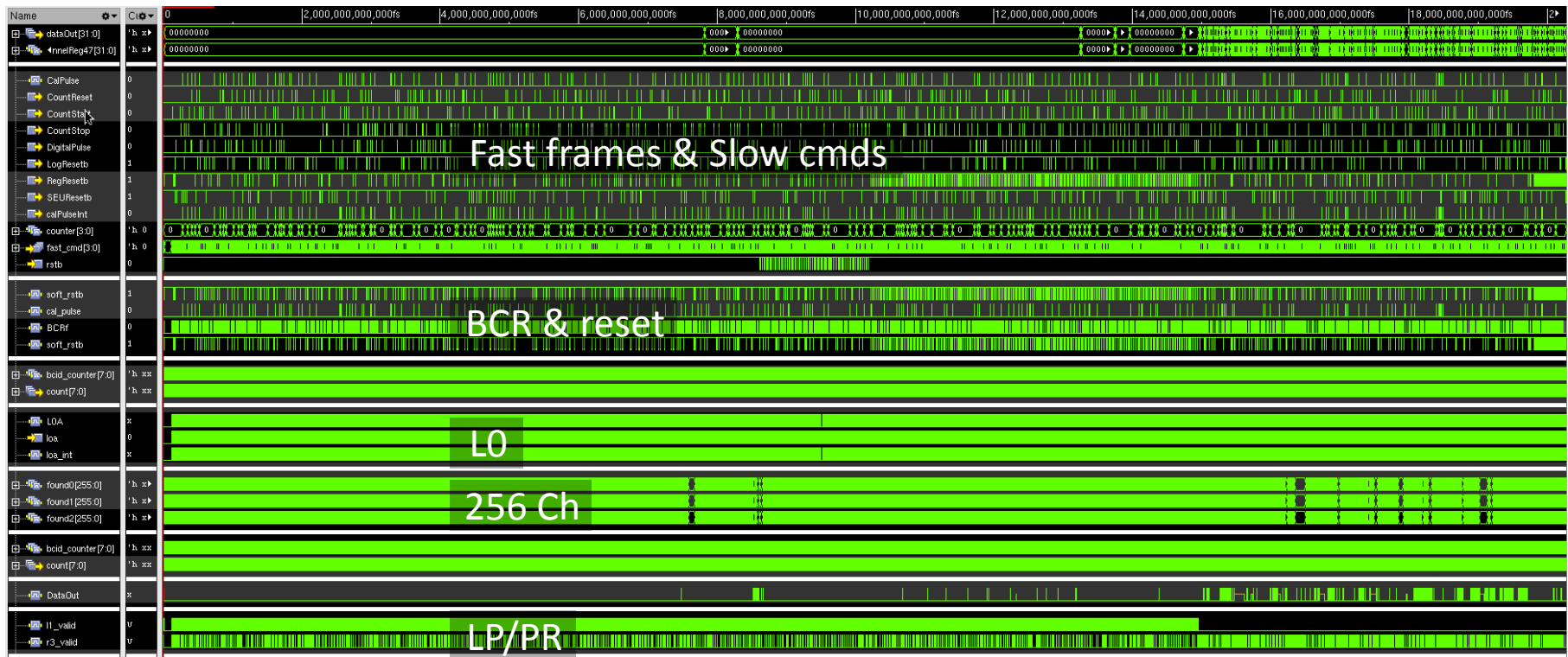
JIRA

16/Oct/17 to 19/Dec/17 (Custom) ▾   Refine report ▾